

Notice of References Cited

Application/Control No.

10/829,619

Applicant(s)/Patent Under
Reexamination
FUJII, TAKANORI

Examiner

JONATHAN R. BECKLEY

Art Unit

2625

Page 1 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,365,517 A	11-1994	Kato et al.	370/251
*	B	US-5,774,654 A	06-1998	Maki, Nobuhiko	709/200
*	C	US-5,764,864 A	06-1998	Sujita, Kenji	358/1.14
*	D	US-5,862,202 A	01-1999	Bashoura et al.	379/100.14
*	E	US-6,035,205 A	03-2000	Han, Eun-Bong	455/462
*	F	US-6,049,597 A	04-2000	Satake et al.	379/93.08
*	G	US-6,097,506 A	08-2000	Eda et al.	358/468
*	H	US-6,128,104 A	10-2000	Okabe et al.	358/442
*	I	US-6,377,309 B1	04-2002	Ito et al.	348/554
*	J	US-6,381,038 B1	04-2002	Endo, Hiroshi	358/400
*	K	US-6,385,179 B1	05-2002	Malcolm et al.	370/329
*	L	US-2002/0080415 A1	06-2002	Akimoto et al.	358/402
*	M	US-6,426,809 B1	07-2002	Hayashi et al.	358/529

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

10/829,619

Applicant(s)/Patent Under
Reexamination
FUJII, TAKANORI

Examiner

JONATHAN R. BECKLEY

Art Unit

2625

Page 2 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0016395 A1	01-2003	Kajiwara, Tomohito	358/402
*	B	US-6,522,429 B2	02-2003	Endo, Hiroshi	358/400
*	C	US-6,628,760 B2	09-2003	Mirashrafi et al.	379/88.17
*	D	US-2004/0001224 A1	01-2004	Kajiwara, Tomohito	358/1.15
*	E	US-2004/0024829 A1	02-2004	Tanimoto, Yoshifumi	709/206
*	F	US-2004/0051899 A1	03-2004	Saitoh et al.	358/001.14
*	G	US-2004/0051900 A1	03-2004	Sagiya et al.	358/001.15
*	H	US-2004/0057421 A1	03-2004	Kawabata et al.	370/352
*	I	US-2004/0057568 A1	03-2004	Kawabata et al.	379/220.01
*	J	US-2004/0051896 A1	03-2004	Saitoh et al.	358/001.13
*	K	US-6,756,921 B2	06-2004	Kimura et al.	341/50
*	L	US-2004/0184110 A1	09-2004	Maei et al.	358/400
*	M	US-6,822,764 B1	11-2004	Okabe et al.	358/442

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

10/829,619

Applicant(s)/Patent Under
Reexamination
FUJII, TAKANORI

Examiner

JONATHAN R. BECKLEY

Art Unit

2625

Page 3 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,882,629 B2	04-2005	Odaira, Masahiro	370/252
*	B	US-6,883,016 B1	04-2005	Fujii et al.	709/203
*	C	US-6,947,182 B1	09-2005	Kumagai, Takekazu	358/402
*	D	US-6,956,663 B1	10-2005	Iida, Junichi	358/1.15
*	E	US-6,961,137 B1	11-2005	Tamura, Hiroshi	358/1.15
*	F	US-6,985,478 B2	01-2006	Pogossians et al.	370/352
*	G	US-6,982,811 B2	01-2006	Sato, Hiroyuki	358/1.4
*	H	US-7,002,972 B1	02-2006	Endo, Hiroshi	370/401
*	I	US-7,027,176 B2	04-2006	Tanimoto, Yoshifumi	358/1.15
*	J	US-7,068,846 B1	06-2006	Yaguchi, Hiroyuki	382/232
*	K	US-7,092,379 B1	08-2006	Singh et al.	370/352
*	L	US-7,142,320 B2	11-2006	Tanimoto, Yoshifumi	358/1.15
*	M	US-7,180,637 B2	02-2007	Tanimoto, Yoshifumi	358/402

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

10/829,619

Applicant(s)/Patent Under
Reexamination
FUJII, TAKANORI

Examiner

JONATHAN R. BECKLEY

Art Unit

2625

Page 4 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,213,145 B2	05-2007	Sasmazel, Levent	713/153
*	B	US-7,230,733 B2	06-2007	Adegawa, Tomomichi	358/1.15
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.